S-89530A/89531A Series

0.7 µA Rail-to-Rail CMOS COMPARATOR

MINI ANALOG SERIES

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The mini analog series is a group of ICs that incorporate a general-purpose analog circuit in an ultra-small package.

The S-89530A/89531A Series are CMOS type comparators that feature Rail-to-Rail^{*1} I/O and can be driven at a lower voltage and lower current consumpsion than existing comparators, making the S-89530A/89531A for use in battery-powered compact portable devices.

*1. Rail-to-Rail is a registered trademark of Motorola Inc.

Features

- Can be driven lower voltage than existing general-purpose comparators: $V_{\text{DD}} = 0.9 \text{ V}$ to 5.5 V
- Low current consumption: $I_{DD} = 0.7 \ \mu A \ (Typ.)$
- Rail-to-Rail wide input and output voltage range:

 $V_{CMR} = V_{SS}$ to V_{DD}

5.0 mV max.

- Low input offset voltage:
- Lead-free, Sn100%, halogen-free^{*1}

*1. Refer to "■ Product Code List" for details.

Applications

- Cellular phones
- PDAs
- Notebook PCs
- Digital cameras
- Digital video cameras

Package

Dookogo Nomo	Drawing Code					
Package Name	Package	Таре	Reel			
SC-88A	NP005-B-P-SD	NP005-B-C-SD	NP005-B-R-SD			

Product Code List

T	able 1
Input Offset Voltage	Product Name (Single)
$V_{IO} = 10 \text{ mV max}.$	S-89530ACNC-HCBTFD
$V_{IO} = 5 \text{ mV max}.$	S-89531ACNC-HCCTF

Remark \Box : G, S or U



Rev.4.1_01

Pin Configuration

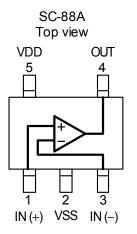


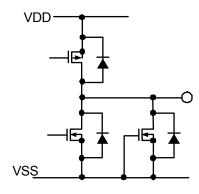
		Table 2	
Pin No.	Symbol	Description	Internal Equivalent Circuit
1	IN(+)	Non-inverted input pin	Figure 3
2	VSS	GND pin	—
3	IN(-)	Inverted input pin	Figure 3
4	OUT	Output pin	Figure 2
5	VDD	Positive power supply pin	Figure 4

Figure 1

Internal Equivalent Circuits

(1) Output pin

(2) Input pin





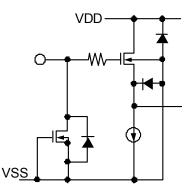
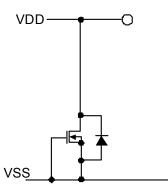


Figure 3



(3) VDD pin



Absolute Maximum Ratings

Table 3

(Ta = 25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Power supply voltage	V_{DD}	V_{SS} –0.3 to V_{SS} +7.0	V
Input voltage	V _{IN}	V _{SS} -0.3 to V _{SS} +7.0 (7.0 max.)	V
Output voltage	V _{OUT}	V _{SS} -0.3 to V _{DD} +0.3 (7.0 max.)	V
Differential input voltage	V _{IND}	±5.5	V
Dewer dissinction	Б	200 (When not mounted on board)	mW
Power dissipation	P _D	350 ^{*1}	mW
Operating temperature	T _{opr}	-40 to +85	°C
Storage temperature	T _{stq}	–55 to +125	°C

*1. When mounted on board

[Mounted board]

(1) Board size : $114.3 \text{ mm} \times 76.2 \text{ mm} \times t1.6 \text{ mm}$

(2) Board name : JEDEC STANDARD51-7

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

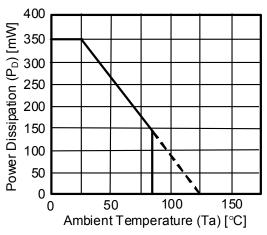


Figure 5 Power Dissipation of Package (When Mounted on Board)

Recommended Operating Voltage Range

Та	able 4		
Parameter	Symbol	Range	Unit
Operating power supply voltage range	V _{DD}	0.9 to 5.5	V

Electrical Characteristics

The S-89530ACNC and S-89531ACNC only differ in the input offset voltage. All other specifications are the same.

1. $V_{DD} = 3.0 V$

Table 5DC Characteristics ($V_{DD} = 3.0 \text{ V}$)(Ta = 25°C unless otherwise specified)							
Parameter	Symbol	Conditions	Min.		Max.	Unit	Measurement circuit
Supply current	I _{DDH}	$V_{IN1}=V_{SS},V_{IN2}=V_{DD},R_L=\infty$		0.7	1.4	μA	Figure 11
	I _{DDL}	$V_{IN1} = V_{DD}, V_{IN2} = V_{SS}, R_L = \infty$		0.25	0.5	P	
Input offset voltage	V _{IO}	S-89530A: V _{CMR} = 1.5 V	-10	±5	+10	mV	Figure 7
input onset voltage	V 10	S-89531A: V _{CMR} = 1.5 V	-5	±3	+5	IIIV	rigure /
Input offset current	I _{IO}	—		1		n۸	
Input bias current	I _{BIAS}	_		1		pА	
Common-mode input voltage range	V_{CMR}		0		3.0	V	Figure 8
Voltage gain (open loop)	A _{VOL}	$V_{CMR} = 1.5$ V, $R_L = 1$ M Ω		86		dB	
Maximum output swing	V _{OH}	$R_L = 1 M\Omega$	2.98			M	Figure 9
voltage	V _{OL}	$R_L = 1 M\Omega$		_	0.02	V	Figure 10
Common-mode input signal rejection ratio	CMRR	$V_{SS} \leq V_{CMR} \leq V_{DD}$	45	65		dB	Figure 8
Power supply voltage rejection ratio	PSRR	$V_{DD} = 0.9 \text{ V}$ to 5.5 V	66	75		dB	Figure 6
Source current ^{*1}		$V_{OUT} = V_{DD} - 0.1 V$	380	500		۸	Eiguro 12
	ISOURCE	$V_{OUT} = 0 V$	4000	5500		μA	Figure 12
Sink ourrant		V _{OUT} = 0.1 V	400	550		۸	Figure 12
Sink current	I _{SINK}	$V_{OUT} = V_{DD}$	4800	6000		μA	Figure 13

*1. Be sure to use the product with a source current of no more than 7 mA.

Table 6

AC Characteristics (VD	_D = 3.0 V)		(Ta = 2	5°C unless	s otherwis	e specified)
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Rise propagation delay time	t _{PLH}		_	110		
Fall propagation delay time	t _{PHL}	Overdrive = 100 mV		280		
Rise response time	t _{TLH}	C _L = 15 pF (Refer to Figure 14) 		10		μs
Fall response time	t _{THL}			30		

2. $V_{DD} = 1.8 V$

Table 7DC Characteristics ($V_{DD} = 1.8 \text{ V}$)(Ta = 25°C unless otherwise specified)								
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	Measurement circuit	
Supply ourropt	I _{DDH}	$V_{IN1}=V_{SS},V_{IN2}=V_{DD},R_L=\infty$		0.7	1.4	μA	Figure 11	
Supply current	I _{DDL}	$V_{\text{IN1}} = V_{\text{DD}}, V_{\text{IN2}} = V_{\text{SS}}, R_{\text{L}} = \infty$		0.25	0.5	μA	Figure 11	
Input offect voltage	V	S-89530A: V _{CMR} = 0.9 V	-10	±5	+10	mV	Eiguro 7	
Input offset voltage	V _{IO}	S-89531A: V _{CMR} = 0.9 V	-5	±3	+5	IIIV	Figure 7	
Input offset current	I _{IO}	—	—	1		n A		
Input bias current	I _{BIAS}	_		1		pА		
Common-mode input voltage range	V_{CMR}		0	_	1.8	V	Figure 8	
Voltage gain (open loop)	A _{VOL}	$V_{CMR} = 0.9$ V, $R_L = 1$ M Ω	_	80		dB		
Maximum output swing	V _{OH}	$R_L = 1 M\Omega$	1.78			V	Figure 9	
voltage	V _{OL}	$R_L = 1 M\Omega$	—		0.02	V	Figure 10	
Common-mode input		$V_{SS} \le V_{CMR} \le V_{DD}$	35	55	_		Figure 0	
signal rejection ratio	CMRR	$V_{SS} \leq V_{CMR} \leq V_{DD} - 0.2 \text{ V}$	45	60	_	dB	Figure 8	
Power supply voltage rejection ratio	PSRR	$V_{DD} = 0.9 V$ to 5.5 V	66	75		dB	Figure 6	
Course ourrent		$V_{OUT} = V_{DD} - 0.1 V$	200	250	_	^	Figure 40	
Source current	ISOURCE	$V_{OUT} = 0 V$	1000	1500		μA	Figure 12	
Cink aumont		V _{OUT} = 0.1 V	220	300		^	Figure 42	
Sink current	I _{SINK}	$V_{OUT} = V_{DD}$	1200	1800		μA	Figure 13	

Table 8

AC Characteristics (V	_{DD} = 1.8 V)		(Ta = 2	5°C unles	s otherwis	e specified)
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Rise propagation delay time	t _{PLH}		_	90		
Fall propagation delay time	t _{PHL}	Overdrive = 100 mV	_	160		
Rise response time	t _{TLH}	C _L = 15 pF (Refer to Figure 14)	_	8		μs
Fall response time	t _{THL}		_	25		

3. $V_{DD} = 0.9 V$

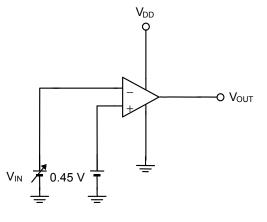
DC Characteristics ($V_{DD} =$	0 9 \/)	Table 9	(T	- a – 24	5°C un	less oth	erwise specified)	
Parameter	Symbol	Conditions	Min.	<u>и – 2</u> с Тур.	Max.	Unit	Measurement circuit	
Supply current	I _{DDH}	$V_{IN1}=V_{SS},V_{IN2}=V_{DD},R_L=\infty$		0.7	1.3		Eiguro 11	
	I _{DDL}	$V_{\text{IN1}} = V_{\text{DD}}, V_{\text{IN2}} = V_{\text{SS}}, R_{\text{L}} = \infty$		0.25	0.5	μA	Figure 11	
Input offect voltage	V	S-89530A: V _{CMR} = 0.45 V	-10	±5	+10	mV	Eiguro 7	
Input offset voltage	V _{IO}	S-89531A: V _{CMR} = 0.45 V	-5	±3	+5	IIIV	Figure 7	
Input offset current	I _{IO}	—		1		۳Å		
Input bias current	I _{BIAS}	—		1		pА		
Common-mode input voltage range	V_{CMR}		0	_	0.9	V	Figure 8	
Voltage gain (open loop)	A _{VOL}	$V_{CMR} = 0.45$ V, $R_L = 1$ M Ω		74		dB	_	
Maximum output swing	V _{OH}	$R_L = 1 M\Omega$	0.88	_		V	Figure 9	
voltage	V _{OL}	$R_L = 1 M\Omega$		_	0.02	V	Figure 10	
Common-mode input		$V_{SS} \le V_{CMR} \le V_{DD}$	25	50			F igure 0	
signal rejection ratio	CMRR	$V_{SS} \leq V_{CMR} \leq V_{DD} - 0.3 \text{ V}$	40	60		dB	Figure 8	
Power supply voltage rejection ratio	PSRR	$V_{DD} = 0.9 \text{ V}$ to 5.5 V	66	75		dB	Figure 6	
Source ourrent		$V_{OUT} = V_{DD} - 0.1 V$	10	45		۸	Eiguro 12	
Source current	ISOURCE	$V_{OUT} = 0 V$	12	70		μA	Figure 12	
Sink ourrant		V _{OUT} = 0.1 V	10	65			Eiguro 12	
Sink current	I _{SINK}	$V_{OUT} = V_{DD}$	12	120		μA	Figure 13	

Table 10

AC Characteristics (V	_{DD} = 0.9 V)		(Ta = 2	5°C unless	s otherwis	e specified)
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Rise propagation delay time	t _{PLH}	Overdrive = 100 mV C _L = 15 pF (Refer to Figure 14)	_	65		
Fall propagation delay time	t _{PHL}		_	65		
Rise response time	t _{TLH}		_	5		μs
Fall response time	t _{THL}			20		

Measurement Circuits

1. Power supply voltage rejection ratio



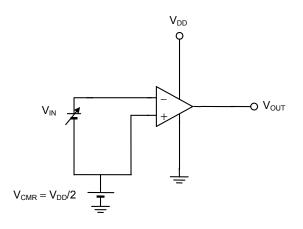
• The power supply voltage rejection ratio (PSRR) is calculated by the following expression, with the value of V_{IO} measured at each V_{DD} .

 $\begin{array}{l} \mbox{Measurement conditions:} \\ \mbox{When } V_{\mbox{DD}} = 0.9 \ \mbox{V:} \ V_{\mbox{DD}} = V_{\mbox{DD1}}, \ \mbox{V}_{\mbox{IO}} = V_{\mbox{IO1}} \\ \mbox{When } V_{\mbox{DD}} = 5.5 \ \mbox{V:} \ \mbox{V}_{\mbox{DD}} = V_{\mbox{DD2}}, \ \mbox{V}_{\mbox{IO2}} = V_{\mbox{IO2}} \\ \end{array}$

$$PSRR = 20log\left(\left|\frac{V_{DD1} - V_{DD2}}{V_{I01} - V_{I02}}\right|\right)$$







- Input offset voltage (V_{IO}) The input offset voltage (V_{IO}) is defined as V_{IN} at which V_{OUT} changes by changing V_{IN}.

Figure 7

3. Common-mode input signal rejection rate, common-mode input voltage range

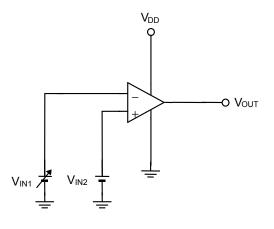
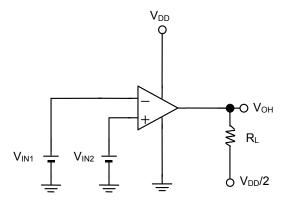


Figure 8

• Common-mode input signal rejection ratio (CMRR) The common-mode input signal rejection ratio, CMRR, can be calculated by the following expression, with the offset voltage (V_{IO}) defined as V_{IN1} minus V_{IN2} at which V_{OUT} is changed by changing V_{IN1} .

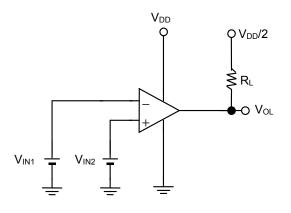
$$CMRR = 20log\left(\left|\frac{V_{CMR}(max.) - V_{CMR}(min.)}{V_{IO1} - V_{IO2}}\right|\right)$$

- Common-mode input voltage range (V_{CMR}) The common-mode input voltage range is the range of V_{IN2} within which V_{OUT} satisfies the common mode input signal rejection ratio specification.
- 4. Maximum output swing voltage



• Maximum output swing voltage (V_{OH}) Measurement conditions: $V_{IN1} = \frac{V_{DD}}{2} - 0.1 V$ $V_{IN2} = \frac{V_{DD}}{2} + 0.1 V$ $R_L = 1 M\Omega$



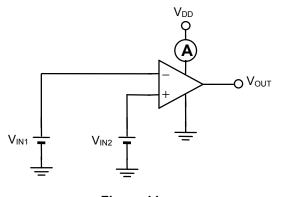


• Maximum output swing voltage (V_{OL}) Measurement conditions: $V_{IN1} = \frac{V_{DD}}{2} + 0.1 V$ $V_{IN2} = \frac{V_{DD}}{2} - 0.1 V$ $R_I = 1 M\Omega$

Figure 10

5. Supply current

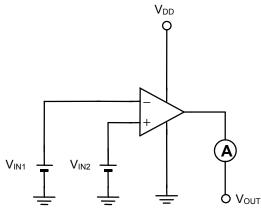
Rev.4.1_01



- Supply current (I_{DDH}) Measurement conditions: $V_{IN1} = V_{SS}$ $V_{IN2} = V_{DD}$
- Supply current (I_{DDL}) Measurement conditions: $V_{IN1} = V_{DD}$ $V_{IN2} = V_{SS}$



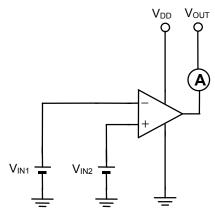
6. Source current



• Source current (I_{SOURCE}) Measurement conditions: $V_{IN1} = \frac{V_{DD}}{2} - 0.1V$ $V_{IN2} = \frac{V_{DD}}{2} + 0.1V$ $V_{OUT} = V_{DD} - 0.1V$ or $V_{OUT} = 0V$

Figure 12

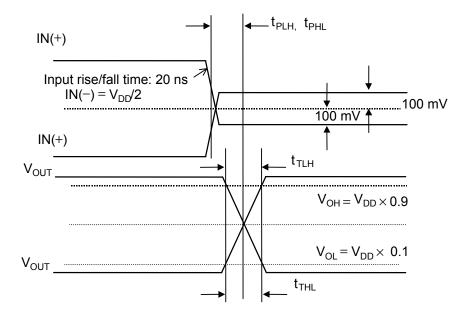
7. Sink current



• Sink current (I_{SINK}) Measurement conditions: $V_{IN1} = \frac{V_{DD}}{2} + 0.1V$ $V_{IN2} = \frac{V_{DD}}{2} - 0.1V$ $V_{OUT} = 0.1 V$ or $V_{OUT} = V_{DD}$

Figure 13

8. Propagation delay time/transient response time





Cautions

• When $R_L = 100 \text{ k}\Omega$, V_{OH} may rise only 0.65 V if the temperature is -40° C and $V_{DD} = 0.9 \text{ V}$.

If the temperature is –20°C, however, V_{OH} rises to 0.8 V, which is 100 mV below V_{DD}, when V_{DD} = 0.9 V, even if $R_L = 100 \text{ k}\Omega$.

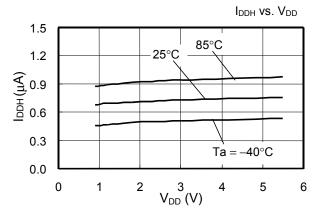
If V_{DD} is 1.2 V, V_{OH} rises to 0.88 V, which is 20 mV below V_{DD} when $R_L = 100 \text{ k}\Omega$, even at -40° C.

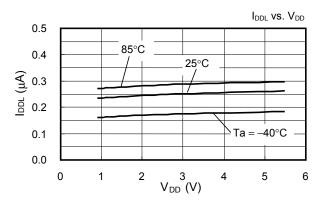
The temperature characteristics data described above can be used as reference data. Note that 100% testing under these conditions has not been performed.

- Be sure to use the product with a source current of no more than 7 mA.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.

■ Characteristics (Reference Data)

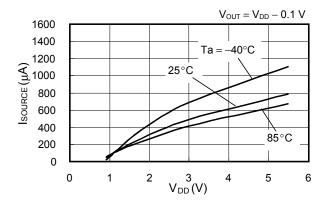
1. Current consumption vs. Power supply voltage



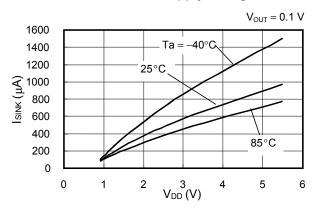


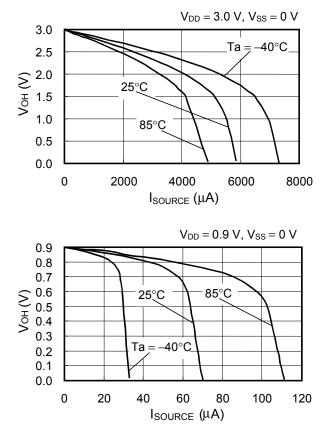
2. Output current

2-1. I_{SOURCE} vs. Power supply voltage

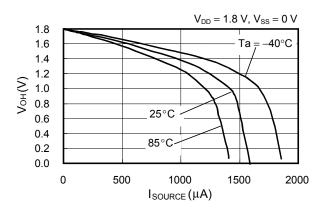


ISINK vs. Power supply voltage

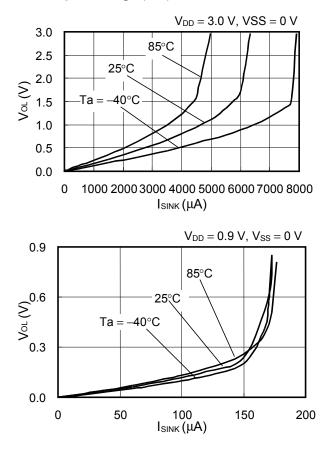


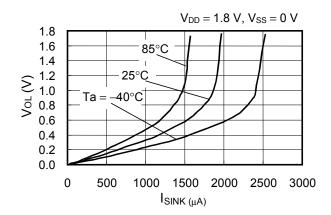


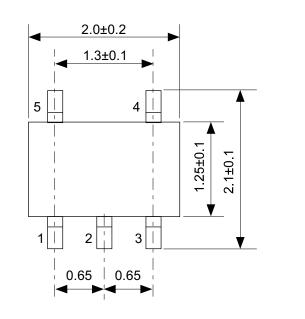
2-2. Output voltage (V_{OH}) vs. I_{SOURCE}

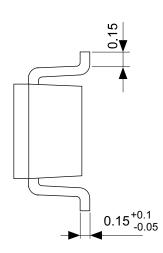


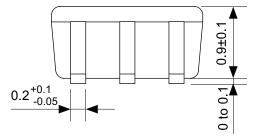
2-3. Output Voltage (Vol) vs. ISINK





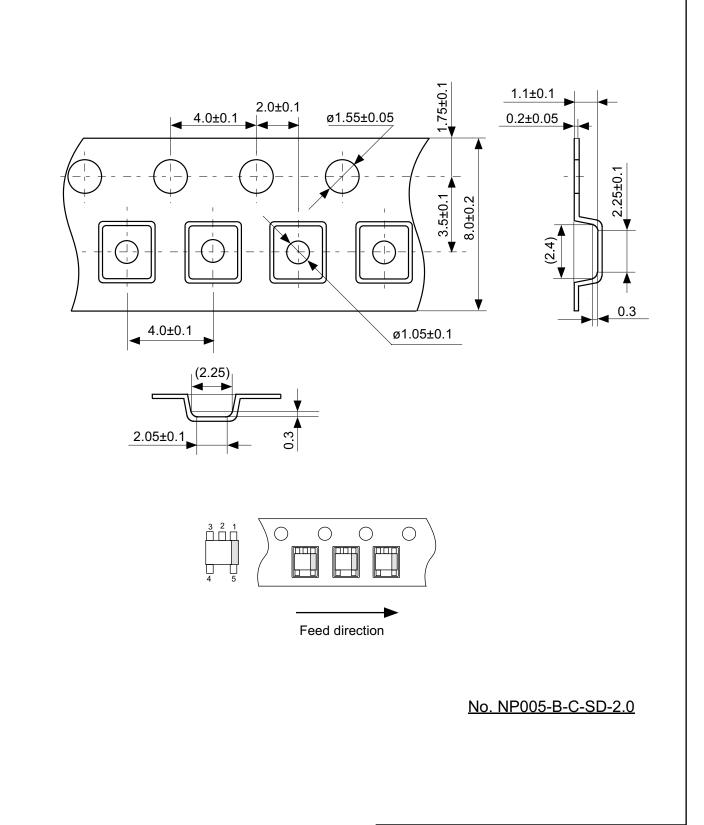




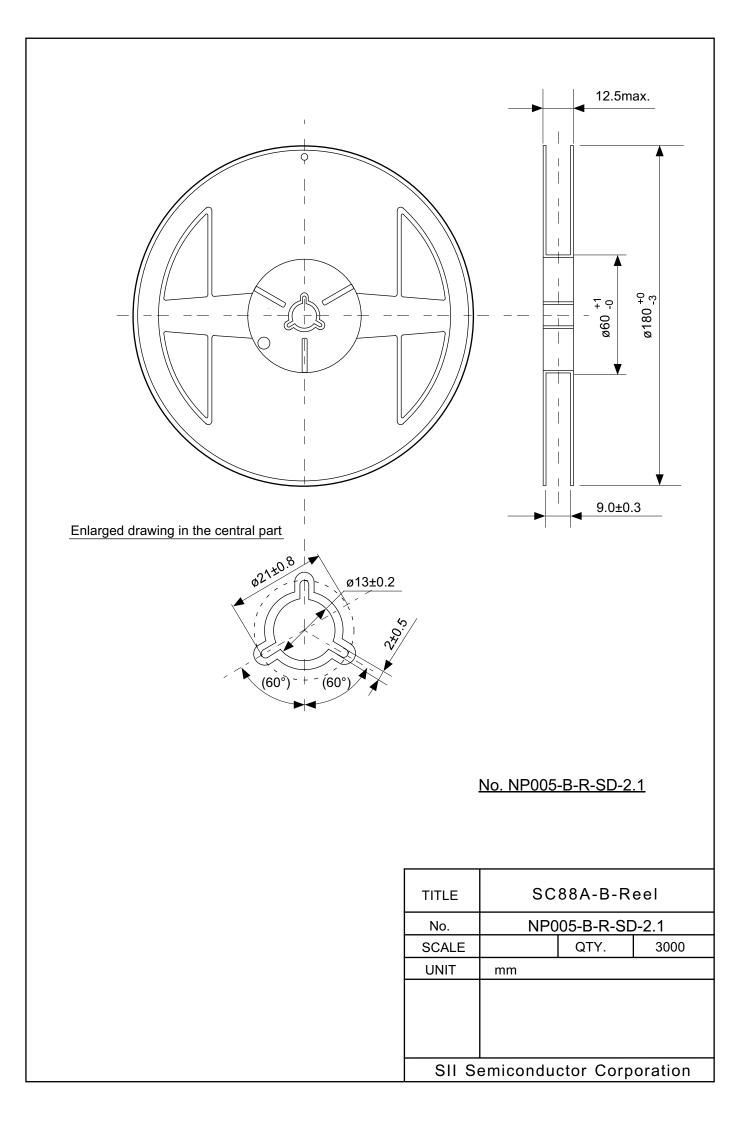


No. NP005-B-P-SD-1.1

TITLE	SC88A-B-PKG Dimensions			
No.	NP005-B-P-SD-1.1			
SCALE				
UNIT	mm			
SII Semiconductor Corporation				



TITLE	SC88A-B-Carrier Tape
No.	NP005-B-C-SD-2.0
SCALE	
UNIT	mm
SII Semiconductor Corporation	



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